DSXXX



November 1994

54F/74F132

Quad 2-Input NAND Schmitt Trigger

General Description

The 'F132 contains four 2-input NAND gates which accept standard TTL input signals and provide standard TTL output levels. They are capable of transforming slowly changing input signals into sharply defined, jitter-free output signals. In addition, they have a greater noise margin than conventional NAND gates.

Each circuit contains a 2-input Schmitt trigger followed by level shifting circuitry and a standard FAST® output structure. The Schmitt trigger uses positive feedback to effectively speed-up slow input transitions, and provide different input

threshold voltages for positive and negative-going transitions. This hysteresis between the positive-going and negative-going input threshold (typically 800 mV) is determined by resistor ratios and is essentially insensitive to temperature and supply voltage variations.

Features

- Guaranteed 4000V minimum ESD protection
- Standard Military Drawing (SMD)
- **5962-89487**

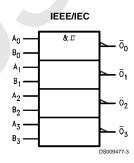
Ordering Code: See Section 0

Commercial	Military	Package	Package Description				
		Number					
74F132PC		N14A	14-Lead (0.300" Wide) Molded Dual-In-Line				
	54F132DM (Note 2)	J14A	14-Lead Ceramic Dual-In-Line				
74F132SC (Note 1)		M14A	14-Lead (0.150" Wide) Molded Small Outline, JEDEC				
74F132SJ (Note 1)		M14D	14-Lead (0.300" Wide) Molded Small Outline, EIAJ				
	54F132FM (Note 2)	W14B	14-Lead Cerpack				
	54F132LM (Note 2)	E20A	20-Lead Ceramic Leadless Chip Carrier, Type C				

Note 1: Devices also available in 13" reel. Use suffix = SCX and SJX.

Note 2: Military grade device with environmental and burn-in processing. Use suffix = DMQB, FMQB and LMQB.

Logic Symbol



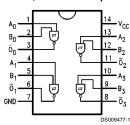
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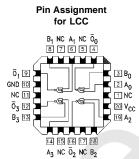
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Connection Diagrams

Pin Assignment for DIP, SOIC and Flatpak





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Unit Loading/Fan Out See Section 0 for U.L. definitions

		54F/74F					
Pin Names	Description	U.L.	Input I _{IH} /I _{IL}				
		HIGH/LOW	Output I _{OH} /I _{OL}				
A _n , B _n	Inputs	1.0/1.0	20 μA/-0.6 mA				
\overline{O}_n	Outputs	50/33.3	-1 mA/20 mA				

Function Table

Inp	uts	Outputs					
Α	В	ō					
L	L	Н					
L	Н	Н					
Н	L	Н					
Н	Н	L					

H = HIGH Voltage Level
L = LOW Voltage Level

Absolute Maximum Ratings (Note 3)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Storage Temperature -65°C to +150°C

Ambient Temperature under Bias -55°C to +125°C

Junction Temperature under Bias -55°C to +175°C

Plastic -55°C to +150°C

 $V_{\rm CC}$ Pin Potential to

Ground Pin -0.5V to +7.0V Input Voltage (Note 4) -0.5V to +7.0V Input Current (Note 4) -30 mA to +5.0 mA

Voltage Applied to Output

in HIGH State (with $V_{CC} = 0V$)

 $\begin{array}{lll} \mbox{Standard Output} & -0.5 \mbox{V to V}_{\rm CC} \\ \mbox{TRI-STATE} \mbox{Output} & -0.5 \mbox{V to +5.5 \mbox{V}} \end{array}$

Current Applied to Output

in LOW State (Max) twice the rated I_{OL} (mA) ESD Last Passing Voltage (Min) 4000V

Recommended Operating Conditions

Free Air Ambient Temperature

Supply Voltage

Military +4.5V to +5.5V Commercial +4.5V to +5.5V

Note 3: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 4: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

Symbol	Parameter		54F/74F			Units	V _{cc}	Conditions	
			Min	Тур	Max				
V _{T+}	Positive-going Threshold		1.5		2.0	V	5.0		
V _{T-}	Negative-going Threshold		0.7		1.1	V	5.0		
ΔV_T	Hysteresis (V _T ⁺ – V _T ⁻)		0.4			V	5.0		
V _{CD}	Input Clamp Diode Vo	tage			-1.2	V	Min	I _{IN} = -18 mA	
V _{OH}	Output HIGH	54F 10% V _{CC}	2.5					I _{OH} = -1 mA	
	Voltage	74F 10% $V_{\rm CC}$	2.5			V	Min	I _{OH} = -1 mA	
		74F 5% $V_{\rm CC}$	2.7					I _{OH} = -1 mA	
V _{OL}	Output LOW	54F 10% V _{CC}			0.5	V	Min	I _{OL} = 20 mA	
	Voltage	74F 10% V _{CC}			0.5			I _{OL} = 20 mA	
I _{IH}	Input HIGH	54F			20.0	μA	Max	V _{IN} = 2.7V	
	Current	74F			5.0				
I _{BVI}	Input HIGH Current	54F			100	μA	Max	V _{IN} = 7.0V	
	Breakdown Test	74F			7.0				
I _{CEX}	Output HIGH	54F			250	μA	Max	V _{OUT} = V _{CC}	
	Leakage Current	74F			50				
V _{ID}	Input Leakage	74F	4.75			V	0.0	I _{ID} = 1.9 μA	
	Test							All Other Pins Grounded	
I _{OD}	Output Leakage	74F			3.75	μΑ	0.0	V _{IOD} = 150 mV	
	Circuit Current							All Other Pins Grounded	
I _{IL}	Input LOW Current				-0.6	mA	Max	V _{IN} = 0.5V	
Ios	Output Short-Circuit C	urrent	-60		-150	mA	Max	V _{OUT} = 0V	
Гссн	Power Supply Current				17.0	mA	Max	V _O = HIGH	
I _{CCL}	Power Supply Current				18.0	mA	Max	V _O = LOW	

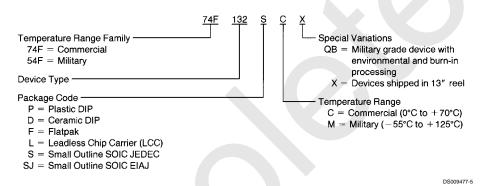
AC Electrical Characteristics

See Section 0 for Waveforms and Load Configurations

Symbol		74F T _A = +25°C V _{CC} = +5.0V C _L = 50 pF		54F T _A , V _{CC} = Mil C _L = 50 pF		74F T _A , V _{CC} = Com C _L = 50 pF		Units		
									Fig.	
	Parameter								No.	
		Min	Тур	Max	Min	Max	Min	Max		
t _{PLH}	Propagation Delay	4.0		10.5	2.0	13.0	3.5	12.0		**-**
t _{PHL}	A_n , B_n to \overline{O}_n	5.0		12.5	4.5	16.0	5.0	13.0	ns	

Ordering Information

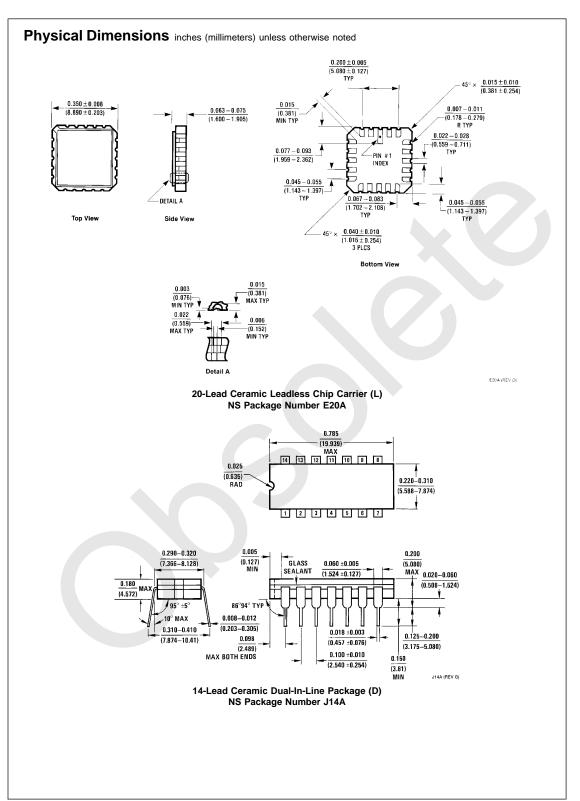
The device number is used to form part of a simplified purchasing code where the package type and temperature range are defined as follows:

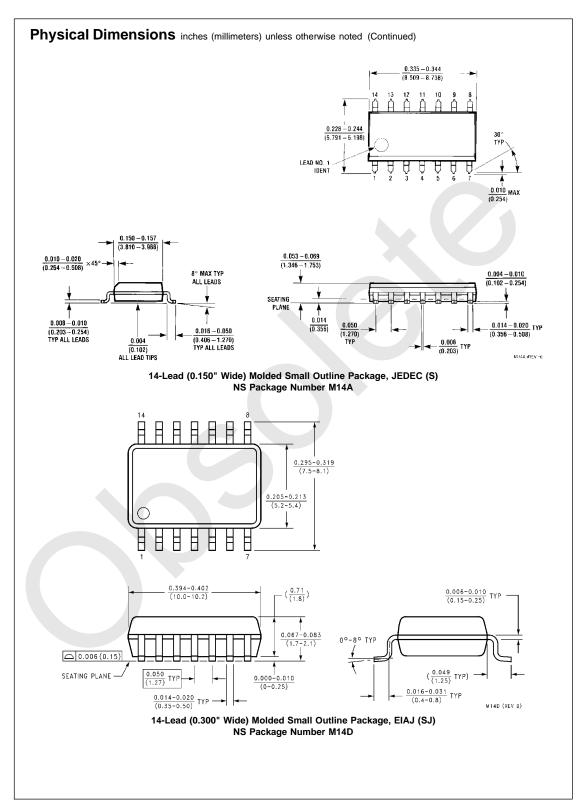


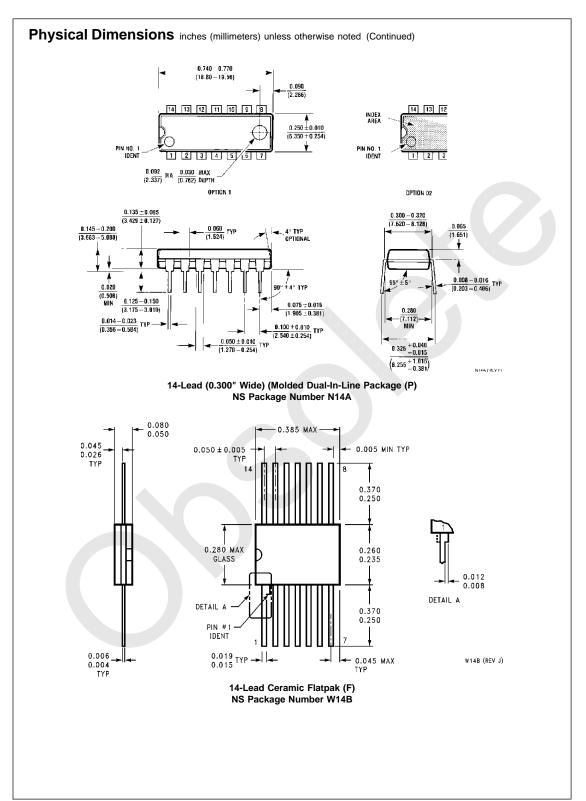
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